Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/011,015	SCHMIDT ET AL.
Examiner	Art Unit
Tam M. Nguyen	1764

SEARCHED			
Class	Subclass	Date	Examiner
585	_. 658		
	654		
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	624		
	625	11/23/2004	TN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
EAST	11/23/2004	TN